

# IRF7904PbF

HEXFET® Power MOSFET

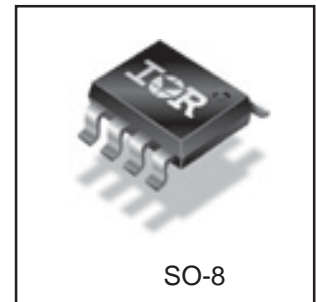
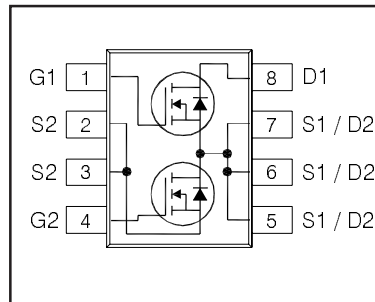
## Applications

- Dual SO-8 MOSFET for POL Converters in Notebook Computers, Servers, Graphics Cards, Game Consoles and Set-Top Box

| $V_{DSS}$ | $R_{DS(on)}$ max                   | $I_D$ |
|-----------|------------------------------------|-------|
| 30V       | Q1 16.2m $\Omega$ @ $V_{GS} = 10V$ | 7.6A  |
|           | Q2 10.8m $\Omega$ @ $V_{GS} = 10V$ | 11A   |

## Benefits

- Very Low  $R_{DS(on)}$  at 4.5V  $V_{GS}$
- Low Gate Charge
- Fully Characterized Avalanche Voltage and Current
- 20V  $V_{GS}$  Max. Gate Rating
- Improved Body Diode Reverse Recovery
- 100% Tested for  $R_G$
- Lead-Free



## Absolute Maximum Ratings

|                          | Parameter   | Q1 Max.      | Q2 Max. | Units         |
|--------------------------|---|--------------|---------|---------------|
| $V_{DS}$                 | Drain-to-Source Voltage                             | 30           |         | V             |
| $V_{GS}$                 | Gate-to-Source Voltage                              | $\pm 20$     |         |               |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | 7.6          | 11      | A             |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | 6.1          | 8.9     |               |
| $I_{DM}$                 | Pulsed Drain Current ①                              | 61           | 89      |               |
| $P_D @ T_A = 25^\circ C$ | Power Dissipation                                   | 1.4          | 2.0     | W             |
| $P_D @ T_A = 70^\circ C$ | Power Dissipation                                   | 0.9          | 1.3     |               |
|                          | Linear Derating Factor                              | 0.011        | 0.016   | W/ $^\circ C$ |
| $T_J$<br>$T_{STG}$       | Operating Junction and<br>Storage Temperature Range | -55 to + 150 |         | $^\circ C$    |

## Thermal Resistance

|                 | Parameter                | Q1 Max. | Q2 Max. | Units        |
|-----------------|--------------------------|---------|---------|--------------|
| $R_{\theta JL}$ | Junction-to-Drain Lead ⑤ | 20      | 20      | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient ④ ⑤  | 90      | 62.5    |              |

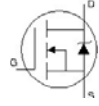
Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

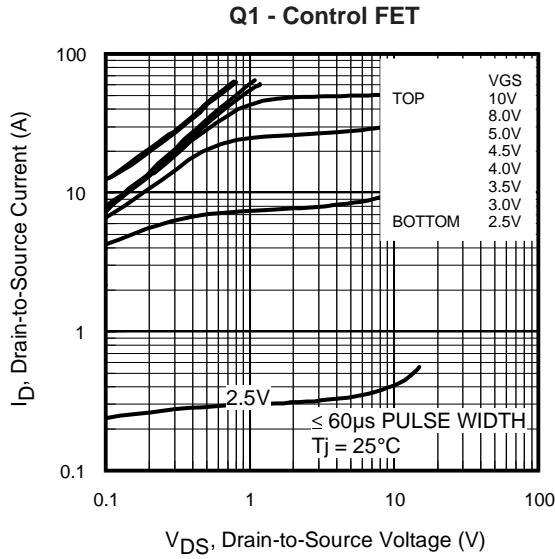
|                                       | Parameter   |       | Min. | Typ.  | Max. | Units | Conditions   |
|---------------------------------------|---|-------|------|-------|------|-------|--|
| BV <sub>DSS</sub>                     | Drain-to-Source Breakdown Voltage                   | Q1&Q2 | 30   | —     | —    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA   |
| ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>   | Breakdown Voltage Temp. Coefficient                 | Q1    | —    | 0.024 | —    | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA  |
|                                       |   | Q2    | —    | 0.024 | —    |       |  |
| R <sub>DS(on)</sub>                   | Static Drain-to-Source On-Resistance                | Q1    | —    | 11.4  | 16.2 | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 7.6A ③   |
|                                       |   |       | —    | 14.5  | 20.5 |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 6.1A ③  |
|                                       |   | Q2    | —    | 8.6   | 10.8 |       | V <sub>GS</sub> = 10V, I <sub>D</sub> = 11A ③  |
|                                       |   |       | —    | 10    | 13   |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8.8A ③  |
| V <sub>GS(th)</sub>                   | Gate Threshold Voltage                              | Q1&Q2 | 1.35 | —     | 2.25 | V     | Q1: V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 25μA<br>Q2: V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 50μA |
| ΔV <sub>GS(th)</sub> /ΔT <sub>J</sub> | Gate Threshold Voltage Coefficient                  | Q1    | —    | -5.0  | —    | mV/°C |  |
|                                       |   | Q2    | —    | -5.0  | —    |       |  |
| I <sub>DSS</sub>                      | Drain-to-Source Leakage Current                     | Q1&Q2 | —    | —     | 1.0  | μA    | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V  |
|                                       |   | Q1&Q2 | —    | —     | 150  |       | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C  |
| I <sub>GSS</sub>                      | Gate-to-Source Forward Leakage                      | Q1&Q2 | —    | —     | 100  | nA    | V <sub>GS</sub> = 20V  |
|                                       | Gate-to-Source Reverse Leakage                      | Q1&Q2 | —    | —     | -100 |       | V <sub>GS</sub> = -20V   |
| g <sub>fs</sub>                       | Forward Transconductance                            | Q1    | 17   | —     | —    | S     | V <sub>DS</sub> = 15V, I <sub>D</sub> = 6.1A   |
|                                       |   | Q2    | 23   | —     | —    |       | V <sub>DS</sub> = 15V, I <sub>D</sub> = 8.8A   |
| Q <sub>g</sub>                        | Total Gate Charge                                   | Q1    | —    | 7.5   | 11   |       |  |
|                                       |   | Q2    | —    | 14    | 21   |       |  |
| Q <sub>gs1</sub>                      | Pre-V <sub>th</sub> Gate-to-Source Charge           | Q1    | —    | 2.2   | —    |       | Q1<br>V <sub>DS</sub> = 15V<br>V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 6.1A   |
|                                       |   | Q2    | —    | 3.7   | —    |       |  |
| Q <sub>gs2</sub>                      | Post-V <sub>th</sub> Gate-to-Source Charge          | Q1    | —    | 0.6   | —    |       | Q2<br>V <sub>DS</sub> = 15V<br>V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8.8A   |
|                                       |   | Q2    | —    | 1.1   | —    |       |  |
| Q <sub>gd</sub>                       | Gate-to-Drain Charge                                | Q1    | —    | 2.5   | —    |       |  |
|                                       |   | Q2    | —    | 4.8   | —    |       |  |
| Q <sub>qodr</sub>                     | Gate Charge Overdrive                               | Q1    | —    | 2.2   | —    |       |  |
|                                       |   | Q2    | —    | 4.4   | —    |       |  |
| Q <sub>sw</sub>                       | Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> ) | Q1    | —    | 3.1   | —    |       |  |
|                                       |   | Q2    | —    | 5.9   | —    |       |  |
| Q <sub>oss</sub>                      | Output Charge                                       | Q1    | —    | 4.5   | —    | nC    | V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V  |
|                                       |   | Q2    | —    | 9.1   | —    |       |  |
| R <sub>G</sub>                        | Gate Resistance                                     | Q1    | —    | 3.2   | 4.8  | Ω     |  |
|                                       |   | Q2    | —    | 2.9   | 4.4  |       |  |
| t <sub>d(on)</sub>                    | Turn-On Delay Time                                  | Q1    | —    | 6.9   | —    |       | Q1<br>V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V<br>I <sub>D</sub> = 6.1A   |
|                                       |   | Q2    | —    | 7.8   | —    |       |  |
| t <sub>r</sub>                        | Rise Time   | Q1    | —    | 7.3   | —    | ns    | Q2<br>V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V<br>I <sub>D</sub> = 8.8A<br>Clamped Inductive Load                         |
|                                       |   | Q2    | —    | 10    | —    |       |  |
| t <sub>d(off)</sub>                   | Turn-Off Delay Time                                 | Q1    | —    | 10    | —    |       |  |
|                                       |   | Q2    | —    | 15    | —    |       |  |
| t <sub>f</sub>                        | Fall Time   | Q1    | —    | 3.2   | —    |       |  |
|                                       |   | Q2    | —    | 4.6   | —    |       |  |
| C <sub>iss</sub>                      | Input Capacitance                                   | Q1    | —    | 910   | —    | pF    | V <sub>GS</sub> = 0V<br>V <sub>DS</sub> = 15V<br>f = 1.0MHz  |
|                                       |   | Q2    | —    | 1780  | —    |       |  |
| C <sub>oss</sub>                      | Output Capacitance                                  | Q1    | —    | 190   | —    |       |  |
|                                       |   | Q2    | —    | 390   | —    |       |  |
| C <sub>rss</sub>                      | Reverse Transfer Capacitance                        | Q1    | —    | 94    | —    |       |  |
|                                       |   | Q2    | —    | 180   | —    |       |  |

### Avalanche Characteristics

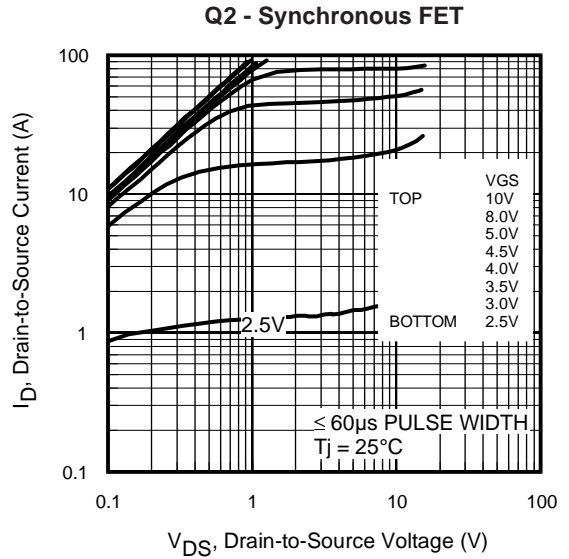
|                 | Parameter                       | Typ. | Q1 Max. | Q2 Max. | Units |
|-----------------|---------------------------------|------|---------|---------|-------|
| E <sub>AS</sub> | Single Pulse Avalanche Energy ② | —    | 140     | 250     | mJ    |
| I <sub>AR</sub> | Avalanche Current ①             | —    | 6.1     | 8.8     | A     |

### Diode Characteristics

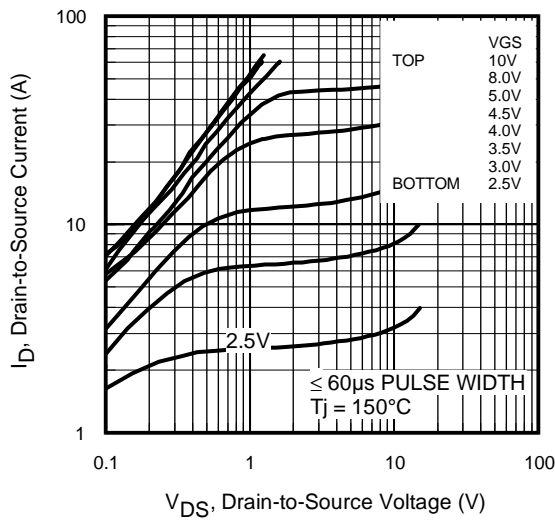
|                 | Parameter                              |    | Min. | Typ. | Max. | Units | Conditions   |
|-----------------|--|----|------|------|------|-------|--|
| I <sub>S</sub>  | Continuous Source Current (Body Diode) | Q1 | —    | —    | 1.8  | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
|                 |  | Q2 | —    | —    | 2.5  |       |  |
| I <sub>SM</sub> | Pulsed Source Current (Body Diode) ①   | Q1 | —    | —    | 61   | A     |  |
|                 |  | Q2 | —    | —    | 88   |       |  |
| V <sub>SD</sub> | Diode Forward Voltage                  | Q1 | —    | —    | 1.0  | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 6.1A, V <sub>GS</sub> = 0V ③   |
|                 |  | Q2 | —    | —    | 1.0  |       | T <sub>J</sub> = 25°C, I <sub>S</sub> = 8.8A, V <sub>GS</sub> = 0V ③   |
| t <sub>rr</sub> | Reverse Recovery Time                  | Q1 | —    | 11   | 17   | ns    | Q1 T <sub>J</sub> = 25°C, I <sub>F</sub> = 6.1A,<br>V <sub>DD</sub> = 15V, di/dt = 100A/μs ③   |
|                 |  | Q2 | —    | 16   | 24   |       |  |
| Q <sub>rr</sub> | Reverse Recovery Charge                | Q1 | —    | 2.6  | 3.9  | nC    | Q2 T <sub>J</sub> = 25°C, I <sub>F</sub> = 8.8A,<br>V <sub>DD</sub> = 15V, di/dt = 100A/μs ③   |
|                 |  | Q2 | —    | 6.9  | 10   |       |  |



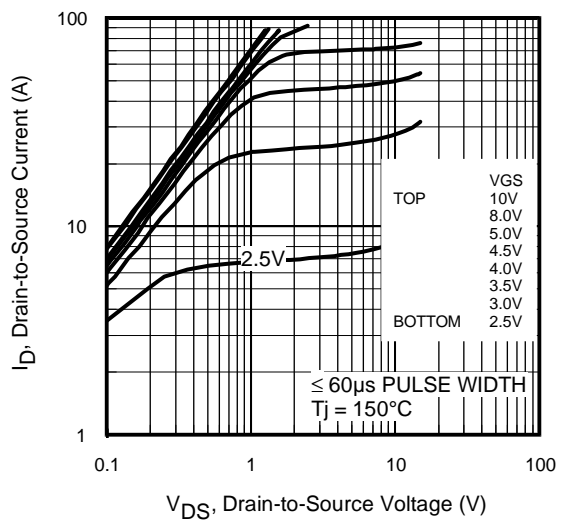
**Fig 1.** Typical Output Characteristics



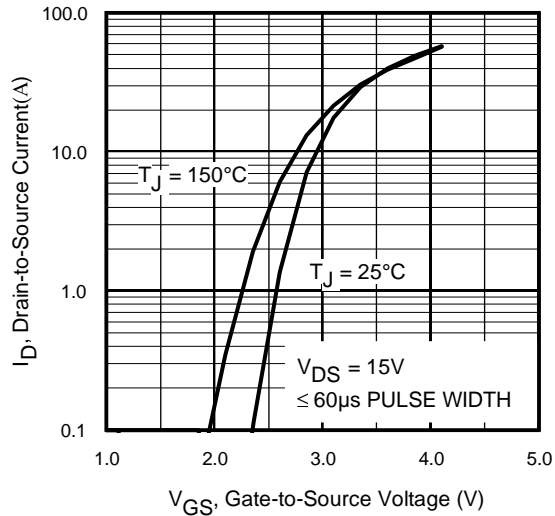
**Fig 2.** Typical Output Characteristics



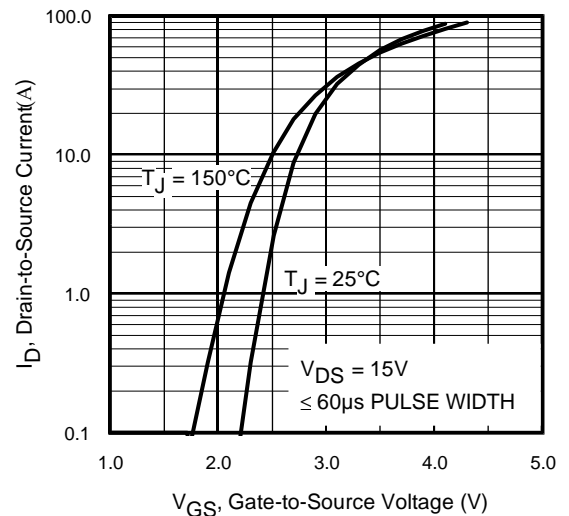
**Fig 3.** Typical Output Characteristics



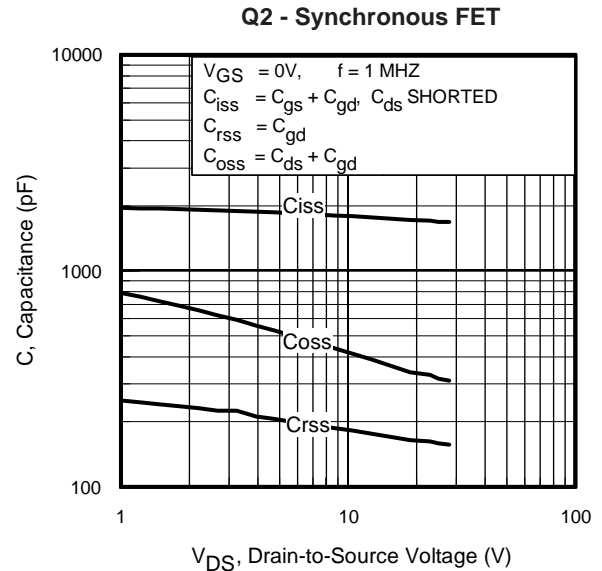
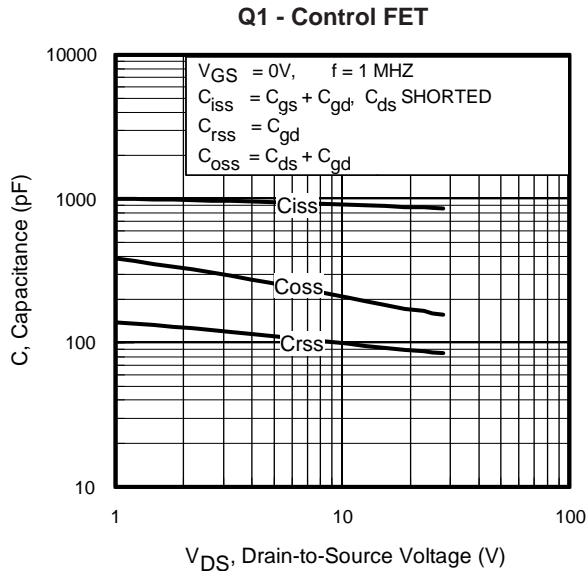
**Fig 4.** Typical Output Characteristics



**Fig 5.** Typical Transfer Characteristics

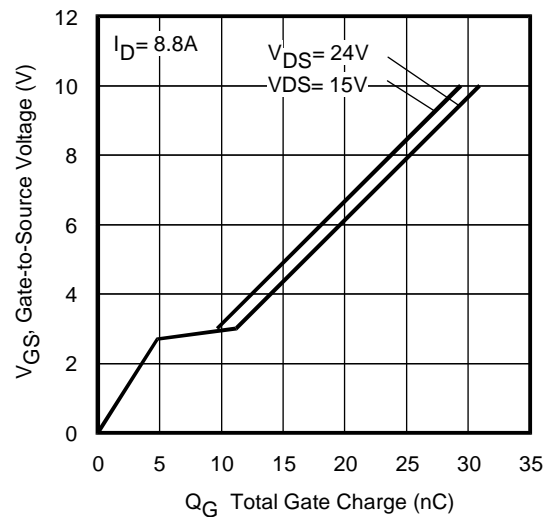
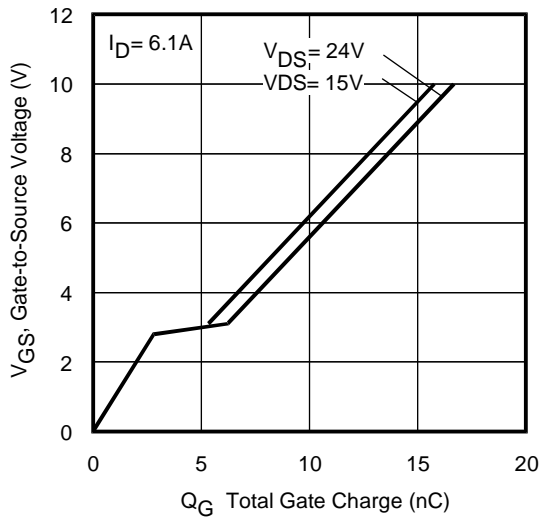


**Fig 6.** Typical Transfer Characteristics



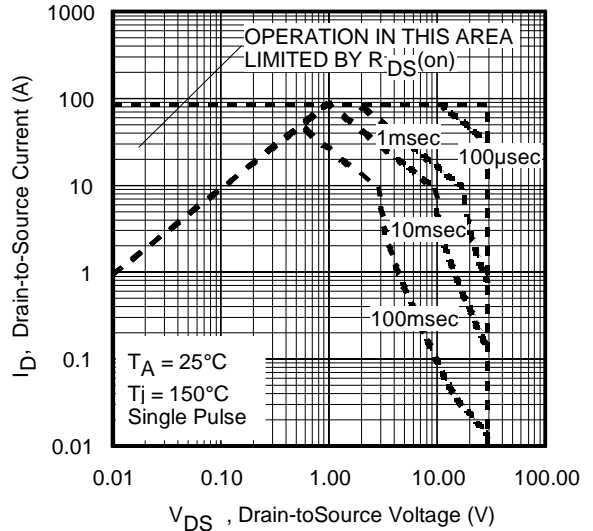
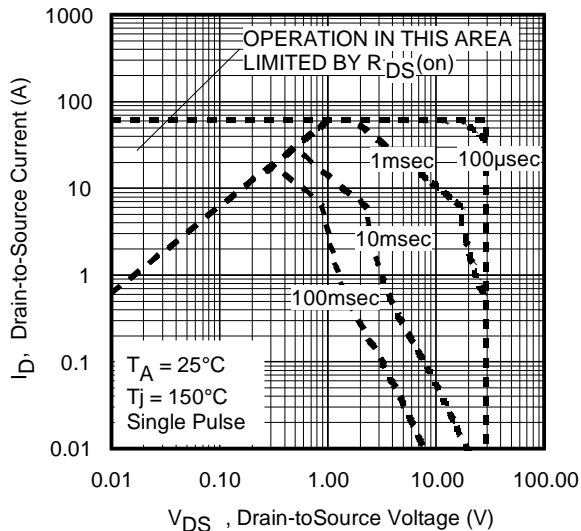
**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig 8.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 9.** Typical Gate Charge vs. Gate-to-Source Voltage

**Fig 10.** Typical Gate Charge vs. Gate-to-Source Voltage



**Fig 11.** Maximum Safe Operating Area

**Fig 12.** Maximum Safe Operating Area

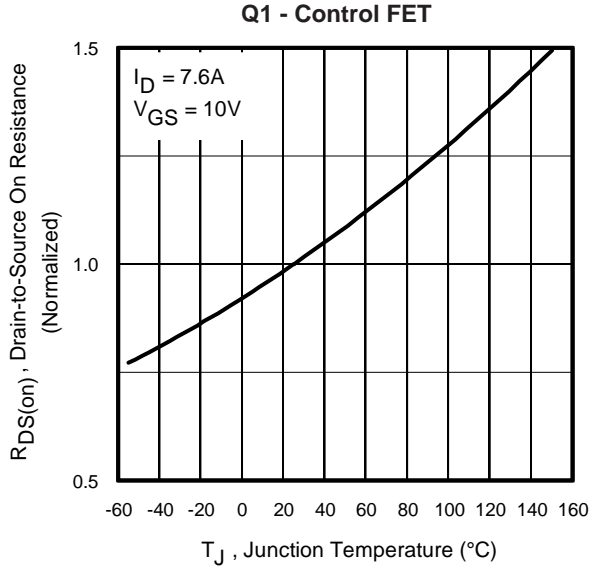


Fig 13. Normalized On-Resistance vs. Temperature

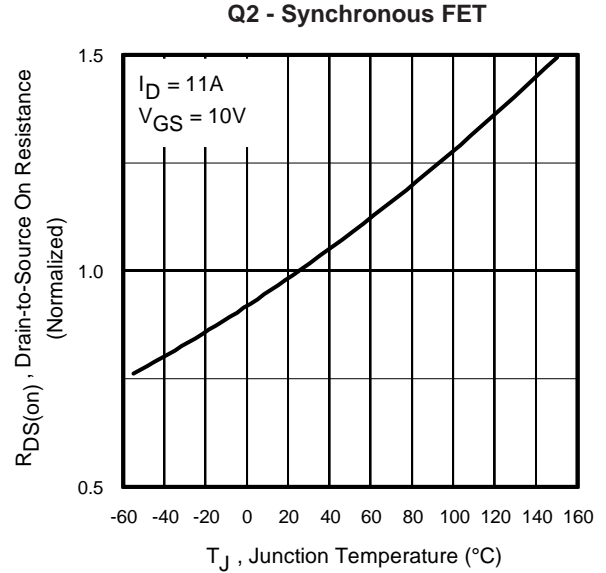


Fig 14. Normalized On-Resistance vs. Temperature

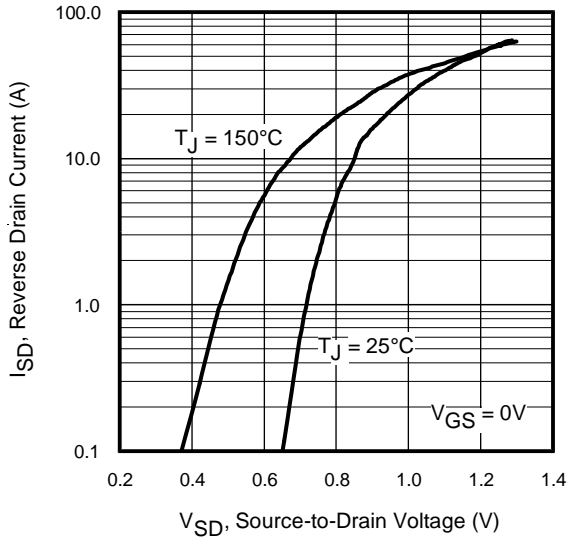


Fig 15. Typical Source-Drain Diode Forward Voltage

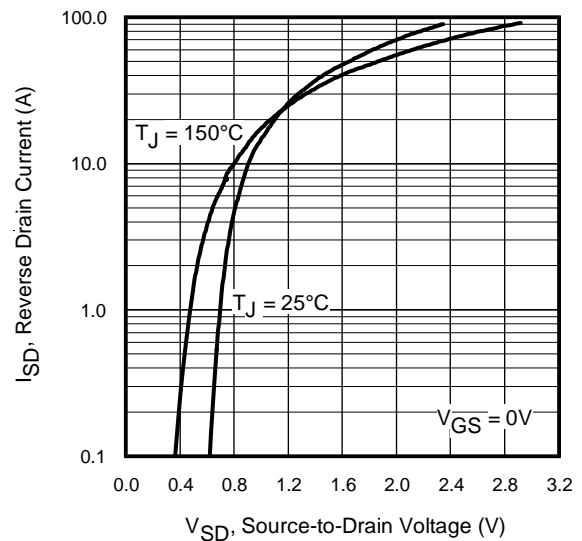


Fig 16. Typical Source-Drain Diode Forward Voltage

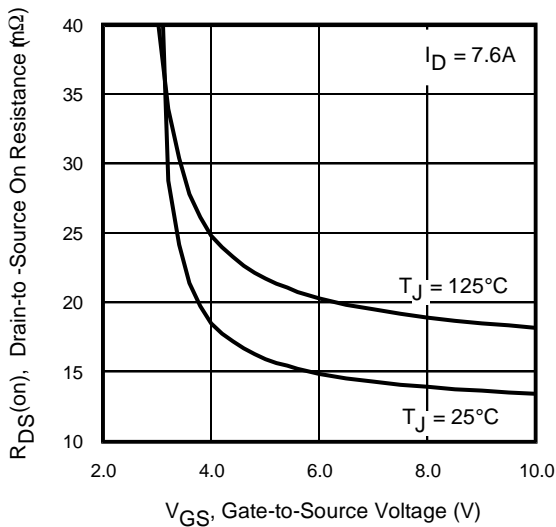


Fig 17. Typical On-Resistance vs. Gate Voltage

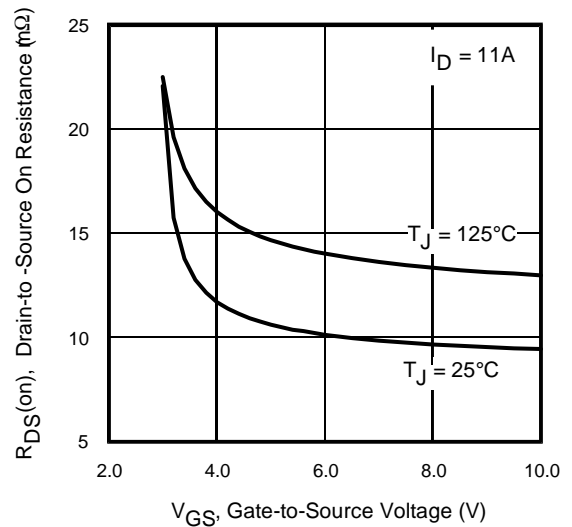
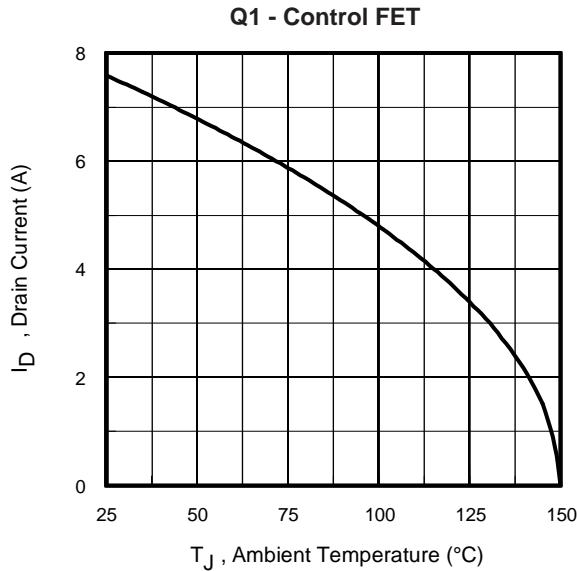
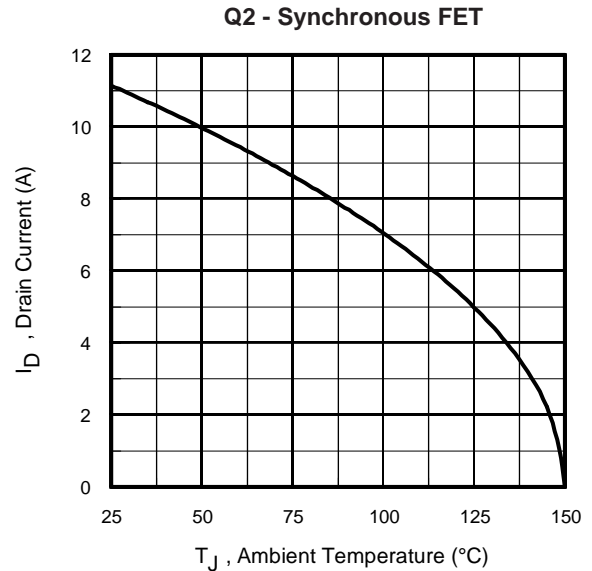


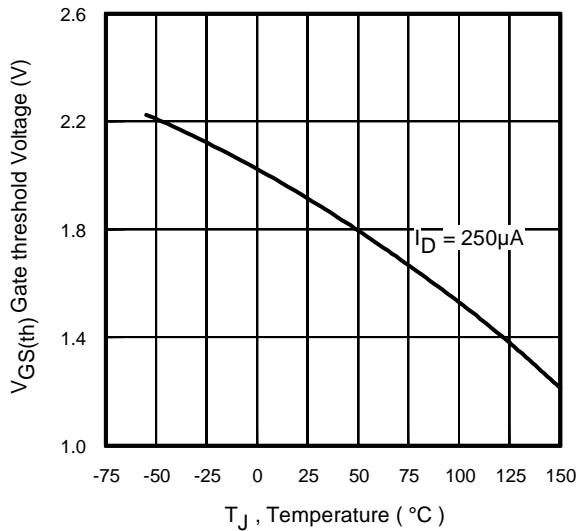
Fig 18. Typical On-Resistance vs. Gate Voltage



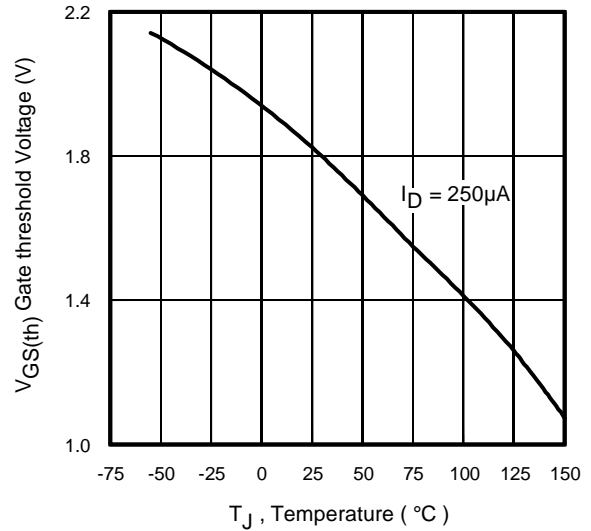
**Fig 19.** Maximum Drain Current vs. Ambient Temp.



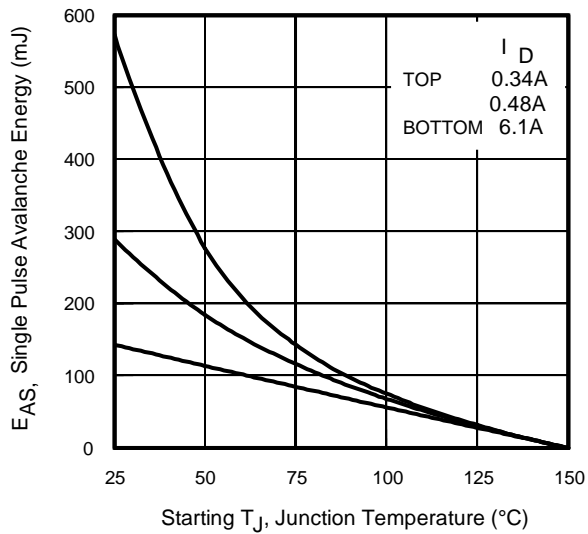
**Fig 20.** Maximum Drain Current vs. Ambient Temp.



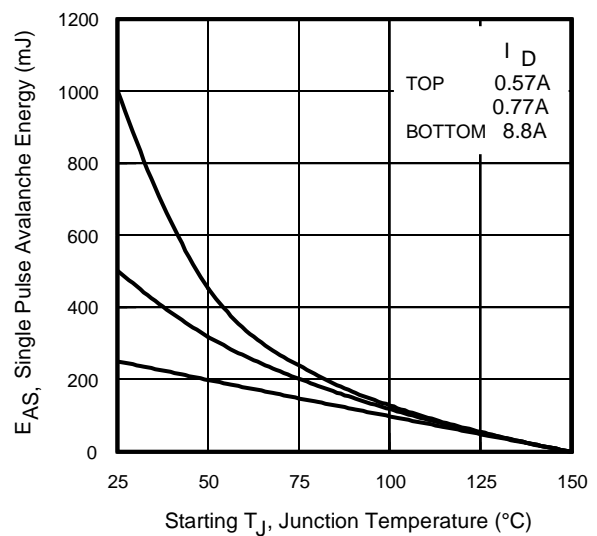
**Fig 21.** Threshold Voltage vs. Temperature



**Fig 22.** Threshold Voltage vs. Temperature



**Fig 23.** Maximum Avalanche Energy vs. Drain Current



**Fig 24.** Maximum Avalanche Energy vs. Drain Current

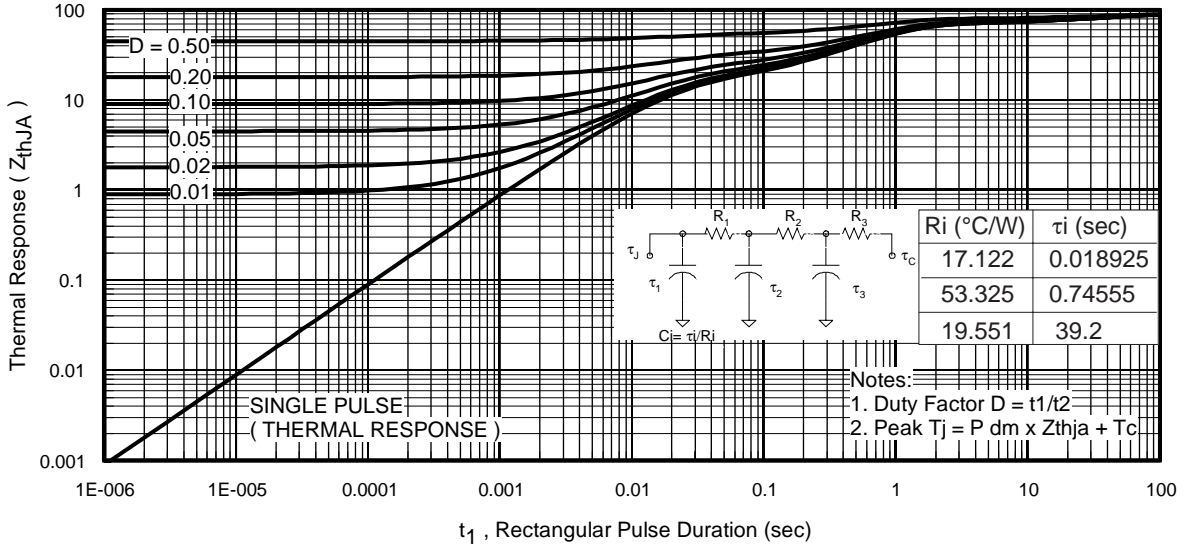


Fig 25. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient (Q1)

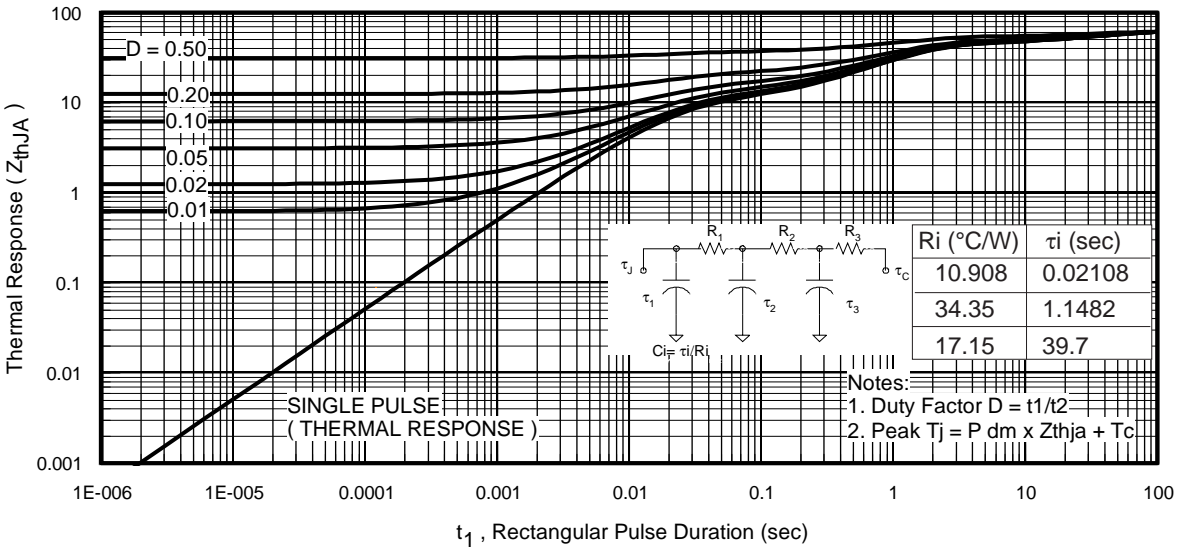


Fig 26. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient (Q2)

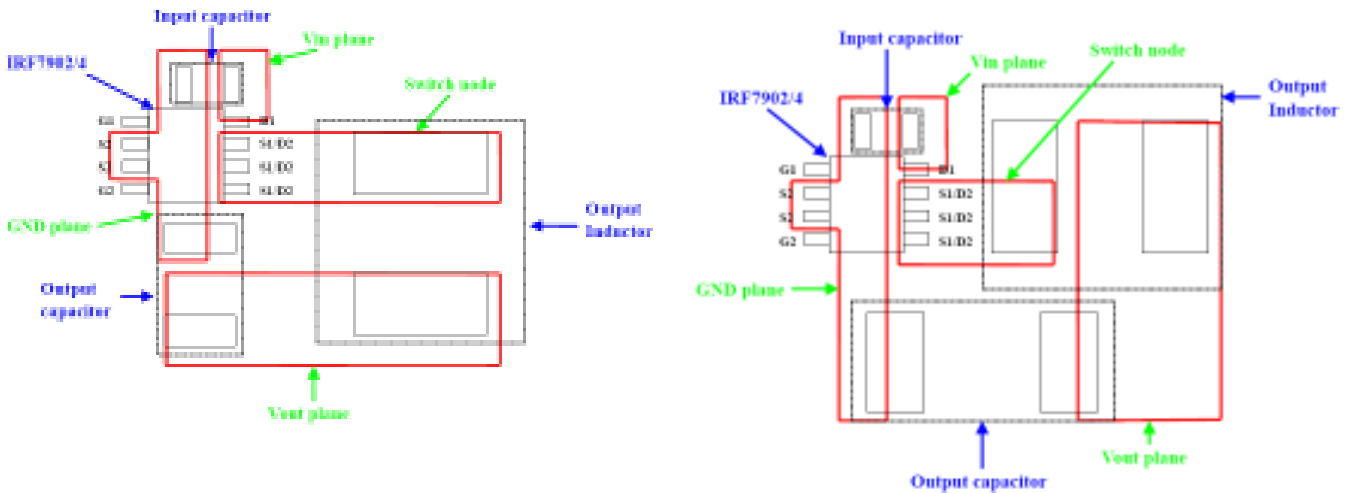
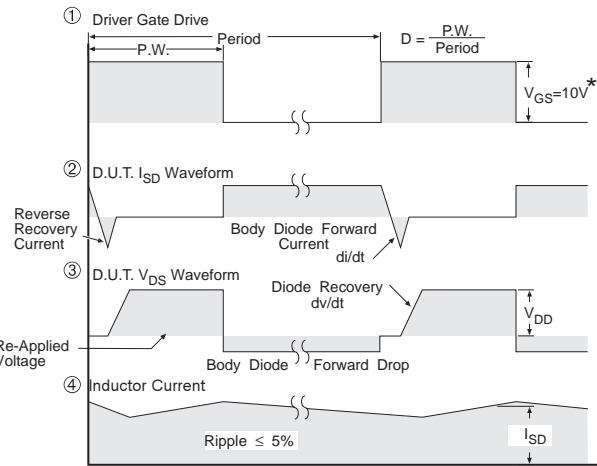
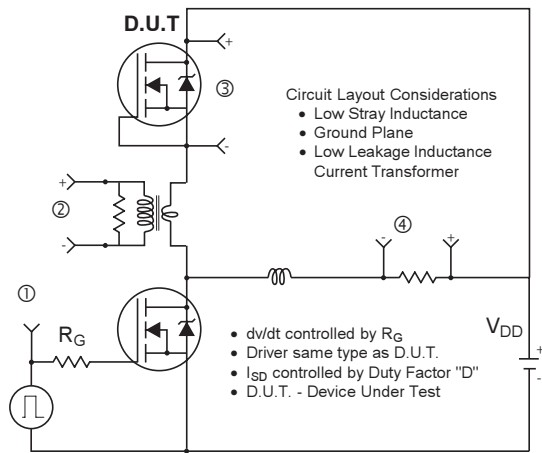
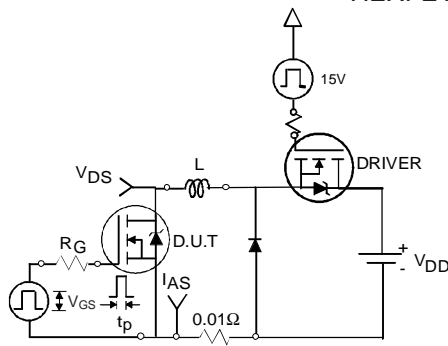


Fig 27. Layout Diagram

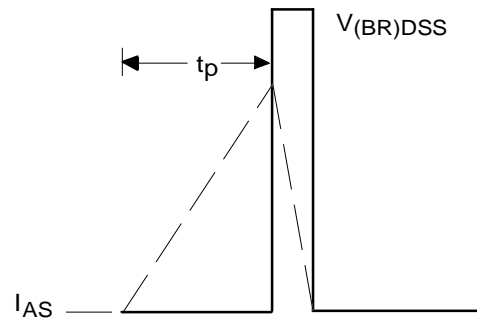


\*  $V_{GS} = 5V$  for Logic Level Devices

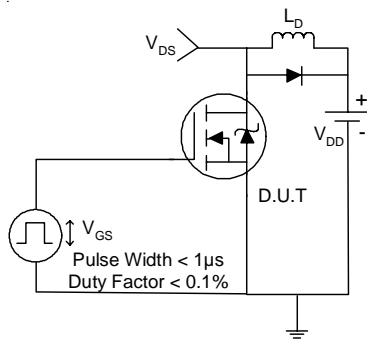
**Fig 28. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET<sup>®</sup> Power MOSFETs**



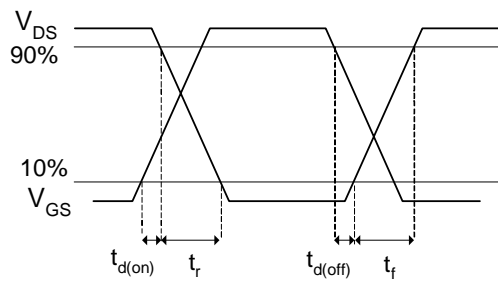
**Fig 29a. Unclamped Inductive Test Circuit**



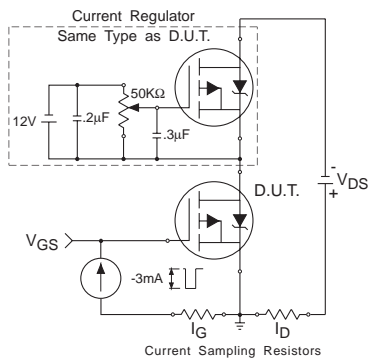
**Fig 29b. Unclamped Inductive Waveforms**



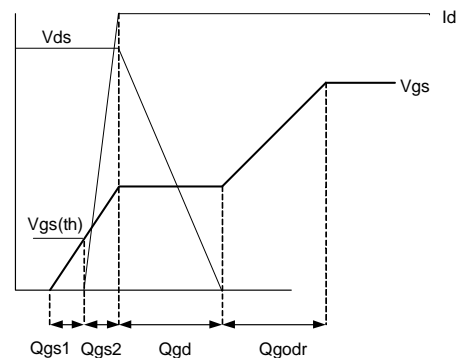
**Fig 30a. Switching Time Test Circuit**



**Fig 30b. Switching Time Waveforms**



**Fig 31a. Gate Charge Test Circuit**

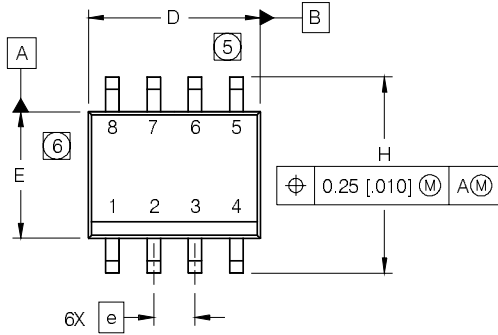


**Fig 31b. Gate Charge Waveform**

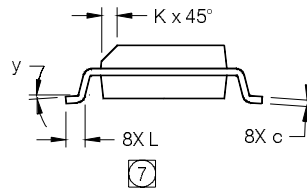
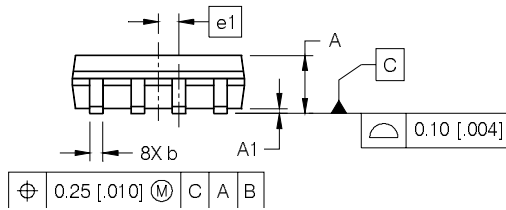


## SO-8 Package Outline

Dimensions are shown in millimeters (inches)



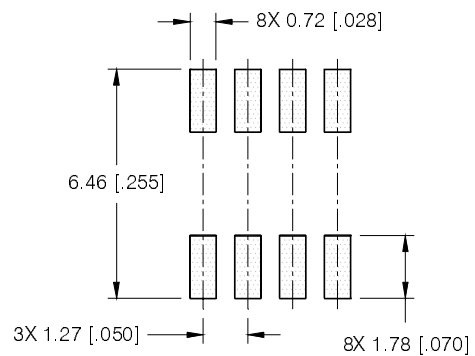
| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e 1 | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |



### NOTES:

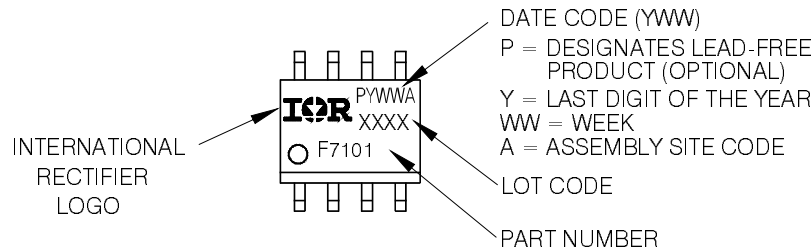
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- ⑤ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
- ⑥ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
- ⑦ DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

### FOOTPRINT



## SO-8 Part Marking

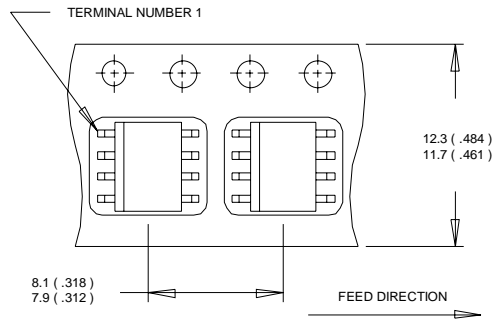
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



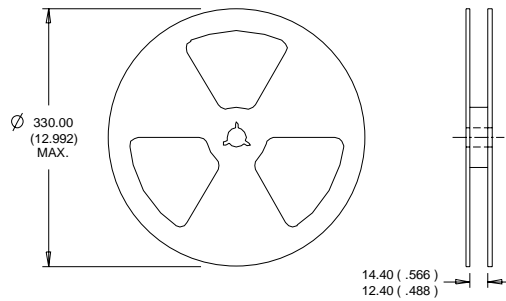
# IRF7904PbF

## SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ , Q1:  $L = 7.7\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 6.1\text{A}$ ; Q2:  $L = 6.5\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 8.8\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board.
- ⑤  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

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